


<b>Search Notes</b> 	<b>Application/Control No.</b> 10727039	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Lee, John W.	<b>Art Unit</b> 2624

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	241	06/14/2007	John W. Lee

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Search	06/14/2007	John W. Lee
EAST Search	06/14/2007	John W. Lee
EAST Search	10/29/2007	John W. Lee

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>